



# Datasheet RS PRO SDM3045X Digital Multimeter

Stock number: 1882476, 1882708, 1882709, 1882711, 1882713





rspro.com

# **Product Overview :**

SDM3045X is a 4½ digit digital (60000 count) multimeter incorporating a dual-display and is especially well suited for the needs of high-precision, multifunction and automatic measurement.

# **Main Function :**

### **Basic Measurement Function**

- DC Voltage: 600 mV 1000 V
- DC Current: 600 µA 10 A
- > AC Voltage: True-RMS, 600 mV 750 V
- > AC Current: True-RMS,60 mA 10 A
- > 2/4-Wire Resistance: 600 Ω 100 MΩ
- ➤ Capacitance: 2 nF 10000 µF
- $\succ$  Continuity Test: Rang e is fixed at 2 k $\!\Omega$
- Diode Test: Adjustable range is 0-4 V
- > Frequency Measurement: 20 Hz 500 KHz
- Period Measurement: 2 µs 0.05 s
- > Temperature: Support for TC and RTD sensor

Max, Min, Average, Standard Deviation, dBm/dB, Relative Measurement ,Pass/Fail Histogram, Trend Chart

# **User-friendly Design :**

- > 4.3" TFT-LCD, 480\*272
- > Support dual display, Chinese and English Menu
- > Built-in front panel accessible help system
- > File management (support for U-disc and local storage)





# **Application fields**

- Research Laboratory
- Development Laboratory
- Detection and Maintenance
- Calibration Laboratory
- Automatic Production Test

#### **Main Features :**

- > Real 41/2 digit (66000 count) readings resolution
- > Up to 150 rdgs/s measurement speed
- > True-RMS AC Voltage and AC Current measuring
- > 1 Gb NAND flash size, Mass storage configuration files and data files
- > Built-in cold terminal compensation for thermocouple
- > With easy, convenient and flexible PC software: EasyDMM
- > Standard interface: USB Device, USB Host, LAN (Optioanal Accessories: USB-GPIB Adapter)

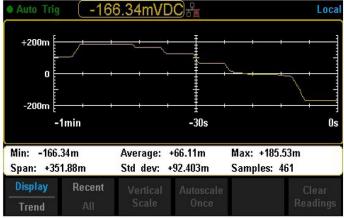
> USB & LAN remote interfaces support common SCPI command set. Compatible with other popular DMMs on the market.

# **Special Features :**

🜆 Histogram



#### 🜆 Trend Chart







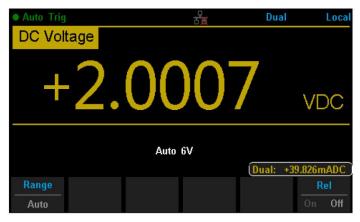
#### 🜆 Bar Chart

# Auto Trig DC Voltage Constrained Local DC Voltage Constrained Display Horizontal Scale

#### Statistics

Auto Trig		<del>р</del> Б <u>ж</u>		Loca
Manual 6V +	5.9	998		VDC
Min: -0.0018	Augra#01	overloadV	Max:	overload V
Span: overloadV	Average: Std dev:	overload V	Samples:	
Low Limit: -1.0000	High Limit:	+7 0000	Status:	Pass
LOW LINIG -1.0000		110000	orariaoi	
Low Failures: 0	High Failu		Statuo	0.000

#### 🜆 Dual Display



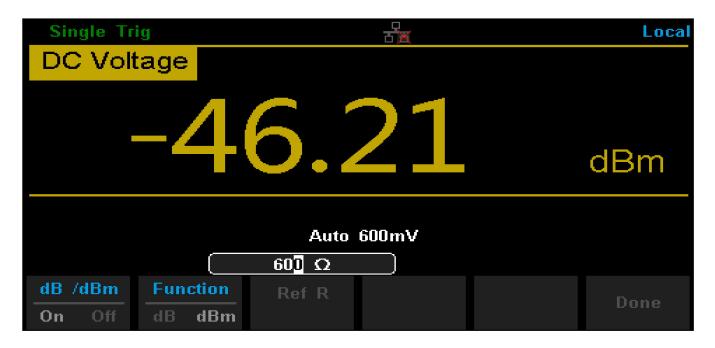
#### Hold Measurement

• Single Trig		<b>B</b>	Dual Loca
DC Voltage	e		
Auto 6V	+1	.1953	VDC
Live: +1.1953	VDC		
1: +2.0006	VDC	5: +2.1936	VDC
2: +2.0997	VDC	6: +5.2312	VDC
3: +1.6055	VDC	7: +07.242	VDC
4: +3.2351	VDC	8: +1.1954	VDC
Probe Hold Be	eeper Off		





# dBm Hold Measurement











# **Specifications**

DC Characteristics Accuracy± (% of Reading + count) <sup>1</sup>				
Function	Range <sup>[2]</sup>	Test current or Load voltage	Resolution	Accuracy (one year; 23℃ ±5℃ )
	600 mV		0.01 mV	0.02+ 6
	6 V		0.0001 V	0.02+ 6
DC Voltage	60 V		0.001 V	0.02+ 6
	600 V		0.01 V	0.02+ 6
	1000 V <sup>[4]</sup>		0.1 V	0.02+ 6
	600 µA	< 33 mV	0.01 µA	0.05+ 3
	6 mA	< 330 mV	0.0001 mA	0.05+ 3
DC Current	60 mA	< 0.05 V	0.001 mA	0.05+ 3
De current	600 mA	< 0.5 V	0.01 mA	0.12+ 6
	6 A	< 0.33 V	0.0001 A	0.20+ 5
	10 A <sup>[5]</sup>	< 0.6 V	0.001 A	0.25+ 4
	600 Ω	1 mA	0.01 Ω	0.08+ 6
	6 ΚΩ	1 00 µA	0.0001 ΚΩ	0.04+ 6
	60 ΚΩ	10 µA	0.001 ΚΩ	0.04+ 6
Resistance <sup>[3]</sup>	600 ΚΩ	1 µA	0.01 ΚΩ	0.08+ 6
	6 ΜΩ	200 nA	0.0001 ΜΩ	0.12+ 3
	60 MΩ	200 nA    10 MΩ	0.001 MΩ	0.85+ 3
	100 MΩ	200 nA    10 MΩ	0.01 ΜΩ	1.75+ 3
Diode Test <sup>[6]</sup>	0-2 V	1 mA	0.0001 V	0.05+ 3
	2-4 V	1 mA	0.0001 V	0.35+ 3
Continuity Test	2000 Ω	1 mA	0.1 Ω	0.05+ 3

#### **Remarks:**

- Specifications are for 0.5 Hour warm-up, "Slow" measurement rate and calibration temperature 18°C 28°C
- > 10% over range on all ranges except for DCV 1000 V, ACV 750 V, DCI 10 A and ACI 10 A
- Specifications are for 4-wire measure or 2-wire measure under "REF" operation. ±0.2 Ω of extra errors will be generated if perform 2-wire measure without "REF" operation
- > Plus 0.02 mV of error per 1 V after the first ±500 VDC
- 30 seconds OFF after 30 seconds ON is recommend foe the continuous current that higher than DC 7 A or AC RMS 7 A
- Accuracy specifications are only for voltage measuring at input terminal. The typical value of current under measure is 1 mA. Voltage drop at diode junction may vary with current supply. Adjustable voltage range : 0- 4 V



Function	Range <sup>[2]</sup>	Frequency Range	Resolution	Accuracy± ( % of Reading + c Accuracy (one year; 23℃ ±5℃ )
		20 Hz – 45 Hz	0.01 mV	2.0 + 20
		45 Hz – 100 Hz	0.01 mV	0.6 +10
	600 mV	100 Hz – 20 KHz	0.01 mV	0.3 + 20
		20 KHz – 50 KHz	0.01 mV	2.0 + 40
		50 KHz –100 KHz	0.01 mV	3.0 + 10
		20 Hz – 45 Hz	0.0001 V	2.0 + 20
		45 Hz – 100 Hz	0.0001 V	0.6 + 10
	6 V	100 Hz – 20 KHz	0.0001 V	0.8 + 20
		20 KHz – 50 KHz	0.0001 V	2.0 + 40
		50 KHz –100 KHz	0.0001 V	3.0 + 40
		20 Hz – 45 Hz	0.001 V	2.0 + 20
		45 Hz – 100 Hz	0.001 V	0.6 + 10
ue-RMS C Voltage <sup>[3]</sup>	60 V	100 Hz – 20 KHz	0.001 V	0.8 + 20
voluge		20 KHz – 50 KHz	0.001 V	2.0 + 40
		50 KHz –100 KHz	0.001 V	3.0 + 40
		20 Hz – 45 Hz	0.01 V	2.0 + 20
		45 Hz – 100 Hz	0.01 V	0.6 + 10
	600 V	100 Hz – 20 KHz	0.01 V	0.8 + 20
		20 KHz – 50 KHz	0.01 V	2.0 + 40
		50 KHz –100 KHz	0.01 V	3.0 + 40
		20 Hz – 45 Hz	0.01 V	2.0 + 20
		45 Hz – 100 Hz <sup>[4]</sup>	0.01 V	0.6 + 10
	750 V	100 Hz – 20 KHz	0.01 V	0.8 + 20
		20 KHz – 50 KHz	0.01 V	2.0 + 40
		50 KHz –100 KHz	0.01 V	3.0 + 40
		20 Hz – 45 Hz	0.001 mA	2.0 + 20
	60 mA	45 Hz – 2 KHz	0.001 mA	0.5 + 20
		2 KHz – 10 KHz	0.001 mA	2.5 + 30
		20 Hz – 45 Hz	0.01 mA	2.0 + 20
	600 mA	45 Hz – 2 KHz	0.01 mA	0.5 + 20
Je-RMS		2 KHz – 10 KHz	0.01 mA	2.5 + 30
Current [5]		20 Hz – 45 Hz	0.0001 A	2.0 + 20
	6 A	45 Hz – 2 KHz	0.0001 A	0.5 + 20
		2 KHz – 10 KHz	0.0001 A	2.5 + 20
		20 Hz – 45 Hz	0.001 A	1.5 + 45
	10 A <sup>[6]</sup>	45 Hz – 2 KHz	0.001 A	0.5 + 35
		2 KHz – 10 KHz	0.001 A	2.5 + 25

Additional wave crest factor error ( not Sine ) <sup>[7]</sup>			
Wave crest coefficient	Error (% Range)		
1-2	0.05		
2-3	0.3		



#### **Remarks**:

- > Specifications are for 0.5 Hour warm-up, "Slow" measurement rate and calibration temperature 18°C 28°C.
- > 10% over range on all ranges except for DCV 1000 V, ACV 750 V, DCI 10 A and ACI 10 A.
- Specifications are for amplitude of sine wave input > 5% of range. For inputs from 1% to 5% of range and <50 kHz, add 0.1% of range extra error. For 50 kHz to 100 kHz, add 0.1% of range extra error.</p>
- > Plus 0.025 V of error per 1 V after the first ±400 VAC.
- Specifications are for sine wave input > 5% of range. 0.1% errors will be added when the range of input sine wave is 1% to 5%.
- 30 seconds OFF after 30 seconds ON is recommend for the continuous current that higher than DC 7 A or AC RMS 7 A.
- For inputs Frequency Range < 100 Hz</p>

#### Frequency and Period Characteristic

Accuracy± (% of Reading + count)<sup>[1]</sup>

Function	Range	Frequency Range	Resolution	Accuracy (one year; 23℃ ±5℃ )
Frequency /Period 600 mV to 750 V <sup>[2]</sup>		20 Hz – 2 KHz		0.01+3
	$600 \text{ m}$ // to 750 $V^{[2]}$	2 KHz – 20 KHz		0.01+2
	600 IIIV to 750 V	20 KHz – 200 KHz		0.01+2
		200 KHz –500 KHz		0.01+2

#### **Remarks:**

- > Specifications are for 0.5 Hour warm-up
- Except for special marks, the AC input voltage is 5% to 110% of range when <100 kHz and 10% to 110% of range when >100 kHz. 750 V range is limited to 750 Vrms. The accuracy is 10 times % of Reading when the measurement range of AC voltage is in 600 mV range





Capacitance Characteristic Accuracy± (% of Reading + count) <sup>[1]</sup>				
Function	Range <sup>[2]</sup>	Max Testing Current	Resolution	Accuracy (one year; 23℃ ±5℃ )
	2 nF	10 µA	0.001 nF	3+10
	20 nF	10 µA	0.01 nF	1+10
	200 nF	100 µA	0.1 nF	1+9
Capacitance	2 µF	100 µA	0.001 µF	1+10
	20 µF	1 mA	0.01 µF	1+10
	200 µF	1 mA	0.1 µF	1+9
	10000 µF	1 mA	1 µF	2+50

#### **Remarks:**

- Specifications are for 0.5 Hour warm-up and "REF" operation. Using of non-film capacitor may generate additional errors.
- > Specifications are for from 1% to 110% on 2 nF range and ranges from 10% to 110% on other ranges.

Temperature Characteristic Accuracy± (% of Reading) <sup>[1]</sup>					Accuracy± (% of Reading) <sup>[1]</sup>
Function	Probe Type	Probe Model	Working Temperature Range	Accuracy (one year; 23℃ ±5℃ )	Temperature       coefficient       0℃ - 18℃       28℃ - 50℃
	RTD <sup>[2]</sup>	a=0.00385	<b>-200°</b> ℃ <b>- 660°</b> ℃	<b>0.16</b> ℃	0.09°C
		В	0℃ - 1820℃	<b>0.76</b> ℃	<b>0.14℃</b>
		E	<b>-270℃ - 1000℃</b>	0.5℃	<b>0.02</b> ℃
		J	<b>-210℃ - 1200</b> ℃	0.5℃	<b>0.02</b> ℃
Temperature	TC <sup>[3]</sup>	К	<b>-270℃ - 1370℃</b>	0.5℃	<b>0.03</b> ℃
		Ν	<b>-270℃ - 1300</b> ℃	0.5℃	<b>0.0</b> 4℃
		R	<b>-50℃ - 1760℃</b>	0.5℃	0.09℃
		S	<b>-50℃ - 1760℃</b>	0.6℃	<b>0.11</b> ℃
		Т	<b>-270℃ - 400℃</b>	0.5℃	<b>0.03</b> ℃

#### **Remarks:**

- Specifications are for 0.5 Hour warm-up, not include probe error.
- Specifications are for 4-wire measure or 2-wire measure under "REF" operation.
- > Built-in cold terminal compensation for thermocouple, accuracy is  $\pm 2^{\circ}$ C.





# Measuring Method and other Characteristics

DC Voltage					
	600 mV 10 MΩ or 10 GΩ selectab	le			
Input Resistance	6 V,60 V, 600 V and 1000 V Range $~~$ 10 $M\Omega$	± 2%			
Input Bias Current	<90 pA, 25°C				
Input Protection	1000 V on all ranges				
CMRR	120 dB (For the 1 K $\Omega$ unbalanced resistance in LO lead, max ±500 VDC)				
NMRR	60 dB at "slow" measurement rate				
Resistance					
Testing Method	4-wire resistance or 2-wire resistance selecta	ble			
Input Protection	1000 V on all ranges				
DC Current					
	600 μA sampling voltage < 33 mV				
Shunt Resistor	6 mA sampling voltage < 0.33 V				
Shuht Resistor	$1\Omega$ for 60 mA, 600 mA 1 $\Omega$				
	0.01 Ω for 6 A, 10 A				
Input Protection	Rear panel : accessible 10 A,250 V fast-melt	fuse			
Input Protection	Internal :12 A,250 V slow-melt fuse				
<b>Continuity/Diode Test</b>	t .				
Measurement Method	1 mA ±5% constant-current source or open-	circuit voltage			
Beeper	yes				
Continuity Threshold	Adjustable				
Input Protection	1000 V				
<b>True-RMS AC Voltage</b>					
Measurement Method	AC Coupled true RMS measure – up to 1000	V DC bias are permitted on every range.			
Wave Crest Factor	≤3 at full scale				
Input Impedance	1 M $\Omega$ $\pm$ 2% in parallel with <100 pF on all ra	$1 \text{ M}\Omega \pm 2\%$ in parallel with <100 pF on all ranges			
AC Filter Bandwidth	20 Hz - 100 KHz				
CMRR	60 dB (For the 1 K $ \Omega$ imbalance resistance am	nong Lo lead and <60 Hz, Max ±500 VDC)			
<b>True-RMS AC Current</b>					
Measurement Method	DC Coupled to the fuse and shunt; AC Couple	ed the True-RMS measurement (measures the AC components only)			
Wave Crest Factor	≤3 at full scale				
Max Input	<10 A (include DC component)				
Shunt Resistor	1 $\Omega$ for 60 mA, 600 mA 1 $\Omega$ ; 0.01 $\Omega$ for 6 A, 10 A				
Input Protection	Rear panel : accessible 10 A,250 V fast-melt fuse				
	Internal :12 A,250 V slow-melt fuse				
Frequency/Period					
Measurement Method	Reciprocal-counting technique, AC Coupled in	Reciprocal-counting technique, AC Coupled input, AC voltage or AC current measurement function			
Measure Attentions					
	errors are leaded into all frequency counters	when measuring low voltage or low frequency signal.			
<b>Capacitance Measurin</b>		when measuring low voltage or low frequency signal.			
Capacitance Measurin Measurement Method	ng	when measuring low voltage or low frequency signal. ated during the current flowing the capacitance			
7	ng				
Measurement Method	Ng Measure the rate of change of voltage genera				
Measurement Method Connection Type	Measure the rate of change of voltage general 2-wire 1000 V on all ranges				
Measurement Method Connection Type Input Protection	Measure the rate of change of voltage general 2-wire 1000 V on all ranges				
Measurement Method Connection Type Input Protection Temperature Measuri	Measure the rate of change of voltage genera 2-wire 1000 V on all ranges				
Measurement Method Connection Type Input Protection Temperature Measuri Measurement Method	Measure the rate of change of voltage genera 2-wire 1000 V on all ranges				
Measurement Method Connection Type Input Protection Temperature Measuri Measurement Method Trigger and Memory	Measure the rate of change of voltage genera 2-wire 1000 V on all ranges ng Support for TC and RTD types of sensor				
Measurement Method Connection Type Input Protection Temperature Measuri Measurement Method Trigger and Memory Samples/Trigger	Measure the rate of change of voltage general 2-wire 1000 V on all ranges Support for TC and RTD types of sensor 1 - 10000	ated during the current flowing the capacitance			
Measurement Method Connection Type Input Protection Temperature Measuri Measurement Method Trigger and Memory Samples/Trigger	Measure the rate of change of voltage genera 2-wire 1000 V on all ranges ng Support for TC and RTD types of sensor 1 - 10000 6 ms - 10000 ms optional	ated during the current flowing the capacitance			
Measurement Method Connection Type Input Protection Temperature Measuri Measurement Method Trigger and Memory Samples/Trigger Trigger Delay	Measure the rate of change of voltage general 2-wire 1000 V on all ranges Support for TC and RTD types of sensor 1 - 10000 6 ms - 10000 ms optional Input Level	ated during the current flowing the capacitance TTL compatible (High level when left input terminal is hanging in the air)			
Measurement Method Connection Type Input Protection Temperature Measuri Measurement Method Trigger and Memory Samples/Trigger Trigger Delay	Measure the rate of change of voltage general 2-wire 1000 V on all ranges Support for TC and RTD types of sensor 1 - 10000 6 ms - 10000 ms optional Input Level Trigger Condition	TTL compatible (High level when left input terminal is hanging in the air) Rising and Falling selectable			
Measurement Method Connection Type Input Protection Temperature Measuri Measurement Method Trigger and Memory Samples/Trigger Trigger Delay	Measure the rate of change of voltage general     2-wire     1000 V on all ranges     Ing     Support for TC and RTD types of sensor     1     1     10000     6 ms - 10000 ms optional     Input Level     Trigger Condition     Input Impedance	ated during the current flowing the capacitance     TTL compatible (High level when left input terminal is hanging in the air)     Rising and Falling selectable     ≥20 KΩ//400 pF ,DC-coupled			
Measurement Method Connection Type Input Protection Temperature Measuri Measurement Method Trigger and Memory Samples/Trigger Trigger Delay	Measure the rate of change of voltage general 2-wire 1000 V on all ranges Support for TC and RTD types of sensor 1 - 10000 6 ms - 10000 ms optional Input Level Trigger Condition Input Impedance Min Pulse	ated during the current flowing the capacitance TTL compatible (High level when left input terminal is hanging in the air) Rising and Falling selectable $\geq 20 \text{ K}\Omega//400 \text{ pF}$ , DC-coupled 500 us			



# **General Specifications**

Power Supply	
AC 100 V - 120 V	45 Hz - 66 Hz
AC 200 V - 240 V	45 Hz - 66 Hz
Consumption	20VA max
Mechanism	
Dimension	293.75 mm×260.27 mm×107.21 mm
Weight	3.76 Kg
<b>Other Characteristics</b>	
Display Screen	4.3" TFT-LCD with resolution 480*272
	Full accuracy from $0^\circ\!\!\mathbb{C}$ to $50^\circ\!\!\mathbb{C}$ , 80% RH and $40^\circ\!\!\mathbb{C}$ , non condensing
Operation Environment	Storage Temperature: -20°C -70°C
Operation Environment	Shock and Vibration: conforming to MIL-T-28800E, , 5 level (only foe sine)
	Height above sea level: up to 3000 meters
electromagnetic compatibility	Conforming to EMC (2004/108/EC) and EN 61326-1:2013
Safety	Conforming to EN61010-1:2010 and low voltage instructions (2006/95/EC)
Remote Interface	10/100 Mbit LAN, USB2.0 Full Speed Device and Host
Programmer Language	Standard SCPI, compatible with commands of main stream multimeters
Warm Up Time	30 minutes

# **Purchase Information**

Standard Accessories	
Power Cord -1	
USB Cable -1	
Quick Start -1	
warranty Card -1	
EasyDMM <sup>[1]</sup>	software system
Test Leads and Alligator Clips -2	
Optional Accessories	
USB-GPIB adapter	USB-GPIB



